



3N65K-MT

Power MOSFET

3A, 650V N-CHANNEL POWER MOSFET

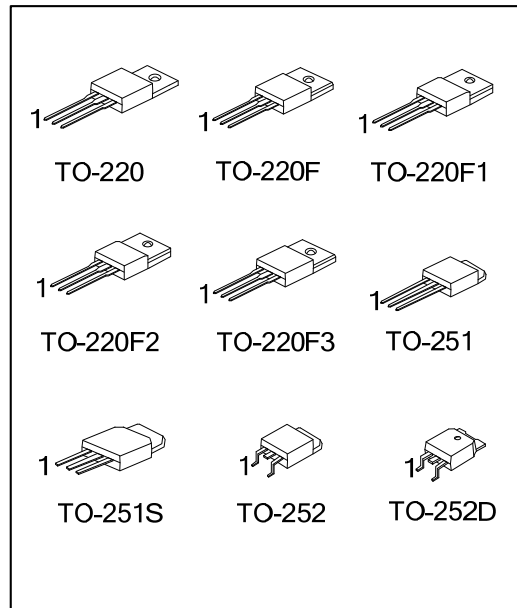
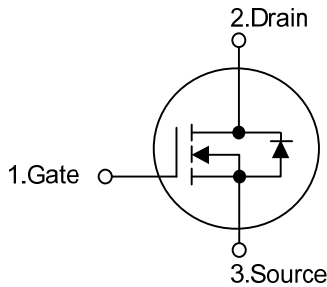
DESCRIPTION

The UTC **3N65K-MT** is a high voltage and high current power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications at power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

FEATURES

- * $R_{DS(ON)} < 3.8\Omega @ V_{GS} = 10V, I_D = 1.5A$
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness

SYMBOL



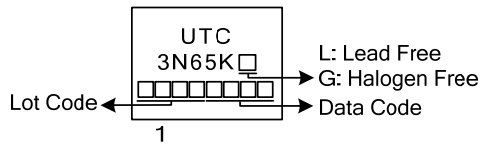
ORDERING INFORMATION

| Ordering Number | | Package | Pin Assignment | | | Packing |
|-----------------|---------------|----------|----------------|---|---|-----------|
| Lead Free | Halogen Free | | 1 | 2 | 3 | |
| 3N65KL-TA3-T | 3N65KG-TA3-T | TO-220 | G | D | S | Tube |
| 3N65KL-TF3-T | 3N65KG-TF3-T | TO-220F | G | D | S | Tube |
| 3N65KL-TF1-T | 3N65KG-TF1-T | TO-220F1 | G | D | S | Tube |
| 3N65KL-TF2-T | 3N65KG-TF2-T | TO-220F2 | G | D | S | Tube |
| 3N65KL-TF3T-T | 3N65KG-TF3T-T | TO-220F3 | G | D | S | Tube |
| 3N65KL-TM3-T | 3N65KG-TM3-T | TO-251 | G | D | S | Tube |
| 3N65KL-TMS-T | 3N65KG-TMS-T | TO-251S | G | D | S | Tube |
| 3N65KL-TN3-R | 3N65KG-TN3-R | TO-252 | G | D | S | Tape Reel |
| 3N65KL-TND-R | 3N65KG-TND-R | TO-252D | G | D | S | Tape Reel |

Note: Pin Assignment: G: Gate D: Drain S: Source

| | |
|---|--|
| <p>3N65KL-TA3-T</p> <p>(1)Packing Type</p> <p>(2)Package Type</p> <p>(3)Green Package</p> | <p>(1) T: Tube, R: Tape Reel</p> <p>(2) TA3: TO-220, TF3: TO-220F, TF1: TO-220F1, TF2: TO-220F2, TF3T: TO-220F3, TM3: TO-251, TMS: TO-251S, TN3: TO-252, TND: TO-252D</p> <p>(3) L: Lead Free, G: Halogen Free and Lead Free</p> |
|---|--|

■ MARKING



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■ ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$, unless otherwise specified)

| PARAMETER | | SYMBOL | RATINGS | UNIT |
|------------------------------------|----------------------------------|-----------|------------|------------------|
| Drain-Source Voltage | | V_{DSS} | 650 | V |
| Gate-Source Voltage | | V_{GSS} | ± 30 | V |
| Avalanche Current (Note 2) | | I_{AR} | 3.0 | A |
| Continuous Drain Current | | I_D | 3.0 | A |
| Pulsed Drain Current (Note 2) | | I_{DM} | 12 | A |
| Avalanche Energy | Single Pulsed (Note 3) | E_{AS} | 90 | mJ |
| | Repetitive (Note 2) | E_{AR} | 7.5 | mJ |
| Peak Diode Recovery dv/dt (Note 4) | | dv/dt | 4.5 | V/ns |
| Power Dissipation | TO-220 | P_D | 75 | W |
| | TO-220F/TO-220F1 | | 34 | |
| | TO-220F3 | | | |
| | TO-220F2 | | 35 | |
| | TO-251/TO-251S TO-252/TO-252D | | 50 | |
| Junction Temperature | | T_J | +150 | $^\circ\text{C}$ |
| Operating Temperature | | T_{OPR} | -55 ~ +150 | $^\circ\text{C}$ |
| Storage Temperature | | T_{STG} | -55 ~ +150 | $^\circ\text{C}$ |

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating : Pulse width limited by T_J .

3. $L=20\text{mH}$, $I_{AS}=3\text{A}$, $V_{DD}=50\text{V}$, $R_G=25\ \Omega$, Starting $T_J = 25^\circ\text{C}$

4. $I_{SD}\leq 3.0\text{A}$, $di/dt\leq 200\text{A}/\mu\text{s}$, $V_{DD}\leq BV_{DSS}$, Starting $T_J = 25^\circ\text{C}$

■ THERMAL DATA

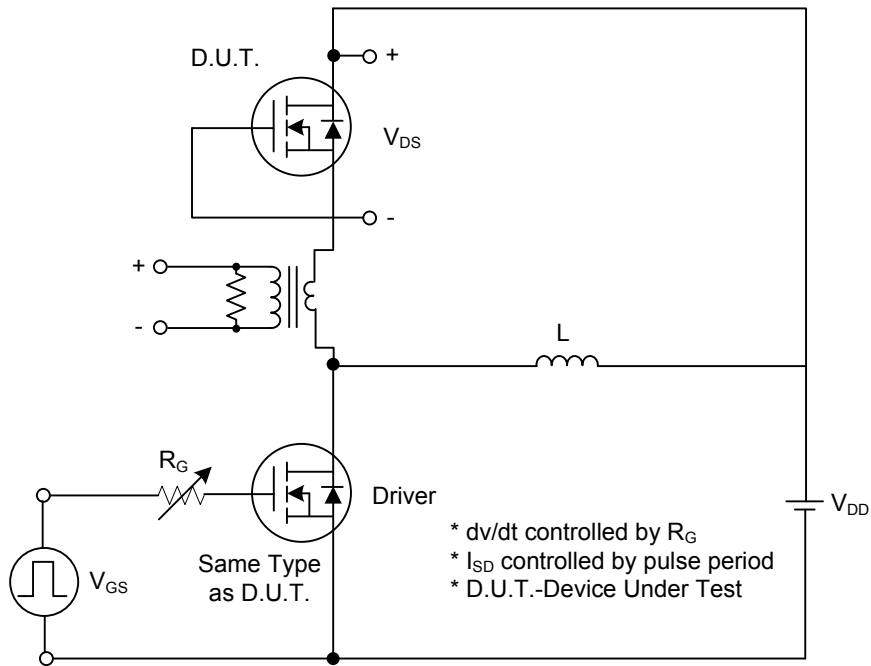
| PARAMETER | | SYMBOL | RATING | UNIT |
|---------------------|---|---------------|--------|---------------------------|
| Junction to Ambient | TO-220/TO-220F TO-220F1/TO-220F2 TO-220F3 | θ_{JA} | 62.5 | $^\circ\text{C}/\text{W}$ |
| | TO-251/TO-251S TO-252/TO-252D | | 110 | |
| Junction to Case | TO-220 | θ_{JC} | 1.67 | $^\circ\text{C}/\text{W}$ |
| | TO-220F/TO-220F1 | | 3.68 | |
| | TO-220F3 | | | |
| | TO-220F2 | | 3.58 | |
| | TO-251/TO-251S TO-252/TO-252D | | 2.5 | |

■ ELECTRICAL CHARACTERISTICS (T_C=25°C, unless otherwise specified)

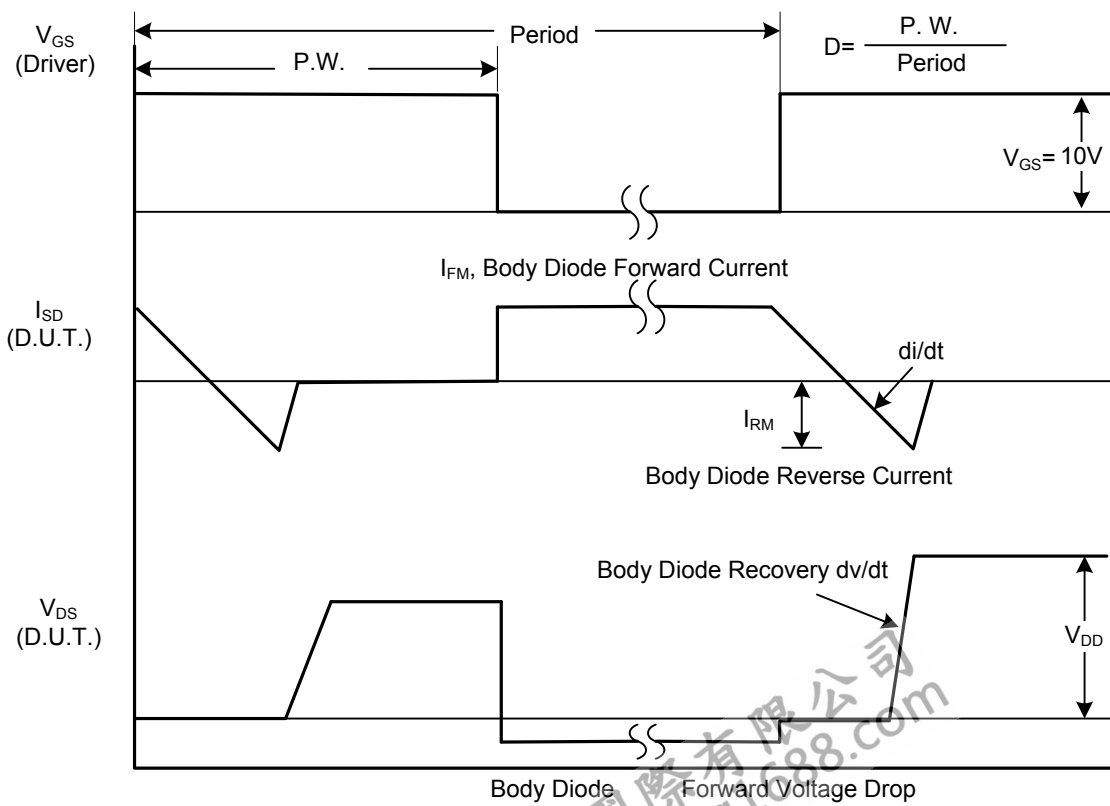
| PARAMETER | SYMBOL | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|-------------------------------------|---|-----|------|------|------|
| OFF CHARACTERISTICS | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | V _{GS} = 0 V, I _D = 250 μA | 650 | | | V |
| Drain-Source Leakage Current | I _{DSS} | V _{DS} = 650 V, V _{GS} = 0 V | | | 10 | μA |
| Gate-Source Leakage Current | Forward | I _{GSS} | | | 100 | nA |
| | Reverse | | | | -100 | nA |
| Breakdown Voltage Temperature Coefficient | ΔBV _{DSS} /ΔT _J | I _D =250μA, Referenced to 25°C | | 0.6 | | V/°C |
| ON CHARACTERISTICS | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | V _{DS} = V _{GS} , I _D = 250 μA | 2.0 | | 4.0 | V |
| Static Drain-Source On-State Resistance | R _{DS(ON)} | V _{GS} = 10V, I _D = 1.5A | | 2.79 | 3.8 | Ω |
| DYNAMIC CHARACTERISTICS | | | | | | |
| Input Capacitance | C _{ISS} | V _{DS} = 25V, V _{GS} = 0V, f = 1MHz | | 303 | 500 | pF |
| Output Capacitance | C _{OSS} | | | 41 | 65 | pF |
| Reverse Transfer Capacitance | C _{RSS} | | | 5.1 | 15 | pF |
| SWITCHING CHARACTERISTICS | | | | | | |
| Turn-On Delay Time | t _{D(ON)} | V _{DD} = 30V, I _D = 0.5A, R _G = 25Ω (Note 1, 2) | | 43 | 60 | ns |
| Turn-On Rise Time | t _R | | | 28 | 50 | ns |
| Turn-Off Delay Time | t _{D(OFF)} | | | 120 | 150 | ns |
| Turn-Off Fall Time | t _F | | | 45 | 70 | ns |
| Total Gate Charge | Q _G | V _{DS} = 50V, I _D = 1.3A, V _{GS} = 10 V (Note 1, 2) | | 13.6 | 16 | nC |
| Gate-Source Charge | Q _{GS} | | | 5.5 | | nC |
| Gate-Drain Charge | Q _{DD} | | | 2.4 | | nC |
| SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS | | | | | | |
| Drain-Source Diode Forward Voltage | V _{SD} | V _{GS} = 0 V, I _S = 3.0 A | | | 1.4 | V |
| Maximum Continuous Drain-Source Diode Forward Current | I _S | | | | 3.0 | A |
| Maximum Pulsed Drain-Source Diode Forward Current | I _{SM} | | | | 12 | A |

- Notes: 1. Pulse Test: Pulse width ≤ 300μs, Duty cycle ≤ 2%
 2. Essentially independent of operating temperature

TEST CIRCUITS AND WAVEFORMS

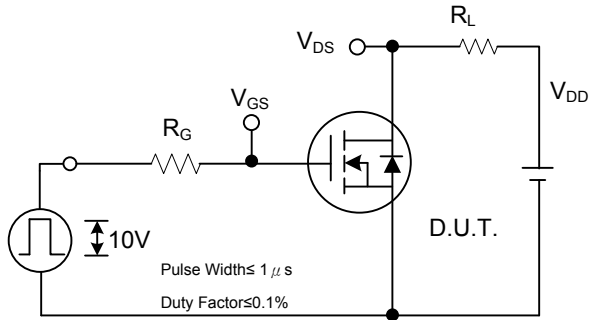


Peak Diode Recovery dv/dt Test Circuit

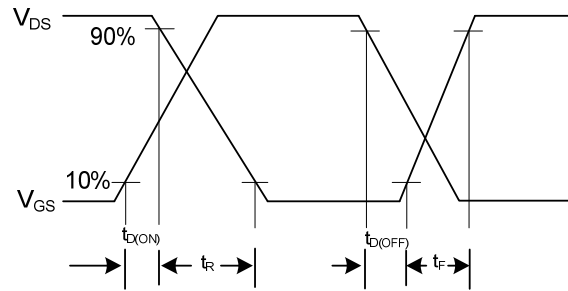


Peak Diode Recovery dv/dt Waveforms

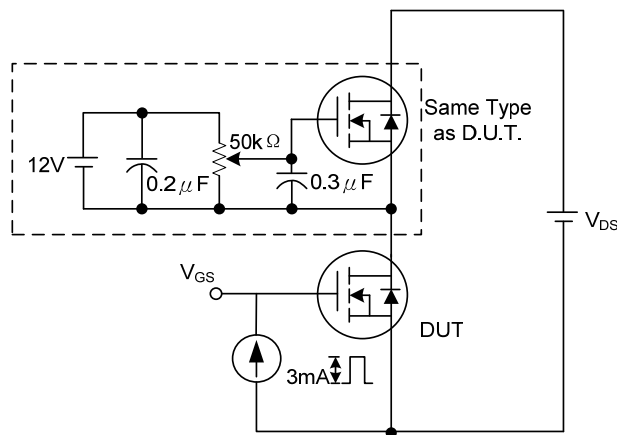
TEST CIRCUITS AND WAVEFORMS (Cont.)



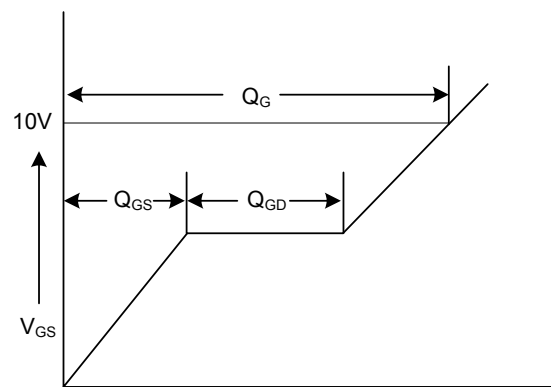
Switching Test Circuit



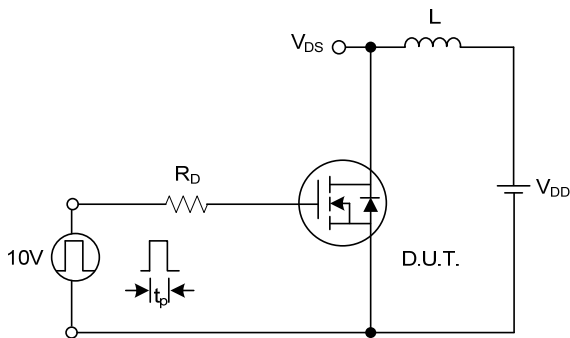
Switching Waveforms



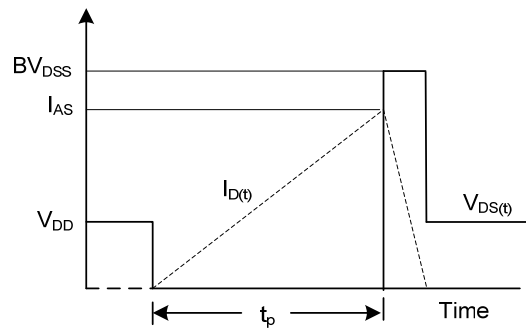
Gate Charge Test Circuit



Gate Charge Waveform

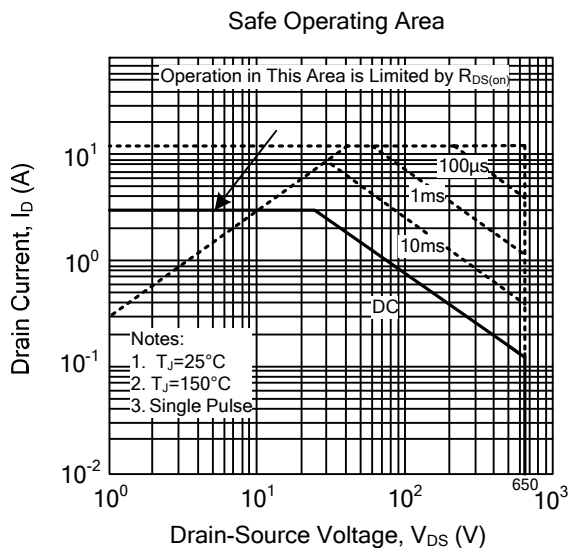
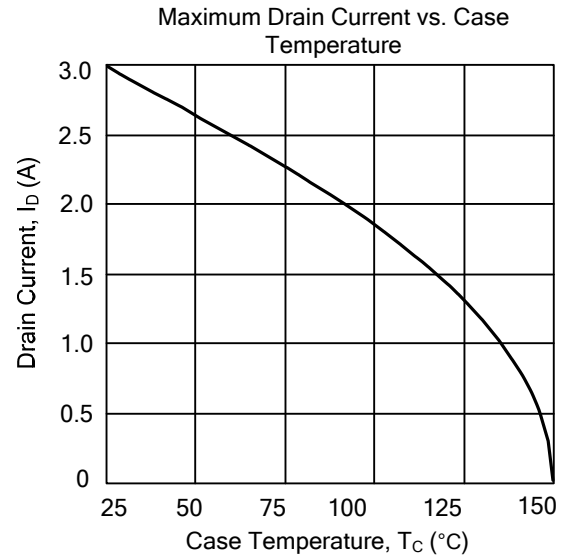
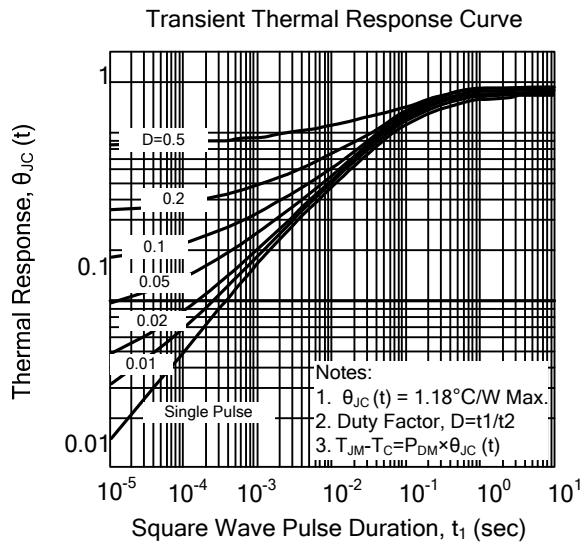


Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

TYPICAL CHARACTERISTICS



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